

Notice of References Cited	Application/Control No. 10/738,474		Applicant(s)/Patent Under Reexamination LIN, YI YEN	
	Examiner LEE NGUYEN		Art Unit 2618	Page 1 of 1

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*	A	US-5,722,055	02-1998	Kobayashi et al.	455/575.8
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NON-PATENT DOCUMENTS

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